


INFORMATION DISCLOSURE CITATION

Atty. Docket No.	04329.3125	Serial No.	10/649,940
Applicant	Katsuhiko OYAMA		
Filing Date	August 28, 2003	Group:	

U.S. PATENT DOCUMENTS						
Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
CAL	6,271,056 B1	08/07/2001	Farnworth et al.	—	—	—

FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
CAL	2002-368185	12/20/2002	Japan	—	—	No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
CAL	Oyama et al.; "LAMINATED-CHIP SEMICONDUCTOR DEVICE"; U.S. Patent Application No. 10/156,819, filed May 30, 2002

Examiner		Date Considered	3/17/05
*Examiner:	Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		
Form PTO 1449		Patent and Trademark Office - U.S. Department of Commerce	

IDS Form PTO/SB/08: Substitute for form 1449A/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Application Number	10/849,940
		Filing Date	August 28, 2003
		First Named Inventor	Katsuhiko OYAMA
		Art Unit	2818
		Examiner Name	Chuong A. Luu
Sheet	1	of	1
		Attorney Docket Number	04329.3125



U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
		US-			
		US-			
		US-			
		US-			
		US-			

Note: Submission of copies of U.S. Patents and published U.S. Patent Applications is not required.

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ³
		Country Code ² Number ⁴ Kind Code ⁵ (if known)				
CA		JP 5-29533	02-05-1993	—	—	N
CA		JP 10-173125	06-26-1998	—	—	N
CA		JP 2002-8227	01-11-2002	—	—	N

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation ³
CA		Notification of Reasons for Rejection from Japanese Patent Office dated August 19, 2005 in Japanese Application No. 2002-254128, and English translation thereof	Y

Examiner Signature	<i>Chuong A. Luu</i>	Date Considered	3/30/2006
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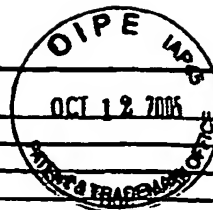
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Sheet 1 of 1	Attorney Docket Number	04329.3125	



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		US-			
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CA		JP 10-173125	06-26-1998	—	—	N
CA		JP 2002-9227	01-11-2002	—	—	N

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